## Generate Admissible Functions using DOPbox

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This function demonstrates the use of the DOPbox for the generation of admissible functions for a BVP and for the solution of the BVP, more details on this method can be found in [1]. prepare the matlab environment

```
1 close all;
2 clear;
3 setUpGraphics;
```

#### 1 Synthesize Admissible Functions

Define the number of points and the number of basis functions to be generated.

```
4 noPts = 100;
 5 \text{ noBfs} = 15;
 6
 7 % Generate the vector of x values at which the problem is to be solved
 9 x = linspace(0,1,noPts)';
10 %
11 % Synthesize the basis functions
12 %
13 [B, dB] = dop(x, noBfs);
15 % generate a local differentiating matrix
16 %
17 \ ls = 3;
18 noBfsD = ls;
19 D = dopDiffLocal(x, ls, noBfsD);
20 %
21 % Compute the second derivative
22 %
23 D2 = D * D;
24 D3 = D2 * D;
25 %-----
26 % Define the constraints
27 %
28 % 1) Position constraint
29 c1 = zeros(noPts, 1);
30 c1(1) = 1;
31 %
32 % 2) derivative constraint
33 c2 = D(1,:)';
34 %
35 % 3) second derivatice constraint
36 c3 = D2(end,:)';
37 %
38 % 4) a positional constraint at 0.7
39 c4 = zeros(noPts, 1);
```

```
40 frac = 0.7;
41 at = round( noPts * frac );
42 \text{ c4(at)} = 1;
43 %
44 c5 = D3(end,:)';
45 %
46 % form the constraint matrix
47 %
48 C = [c1, c2, c3, c4, c5];
49 %
50 % Synthesize the admissible functions
51 %
52 Bc = dopConstrain( C, B );
53 %
54 % plot the first three admissible functions
55 %
56 fig1 = figure;
57 for k=1:3
      plot( x, Bc(:,k), 'k');
58
      hold on;
59
60 end;
61 title('Admissible Functions for the BVP');
62 xlabel('x');
63 ylabel('y(x)');
64 grid on;
```

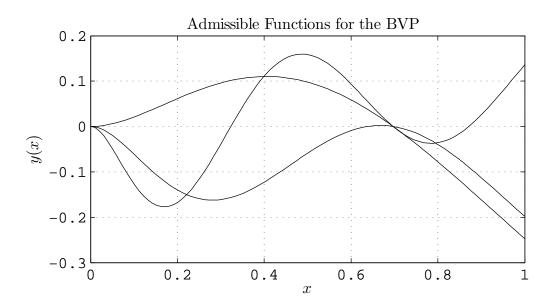


Figure 1: The first three admissible functions.

#### 2 Solve the Differential Equation

Define the linear differential opertor.

```
65 L = Bc' * D^4 * Bc;
67 % Compute the eigenvalues and eigenvectors
69 [vec, val] = eig( L );
70 %
71 % Sort the eigenvalues and vectors in assending order.
73 [val, inds] = sort( diag(val) );
74 \text{vec} = \text{vec}(:, \text{inds});
75 %
76 % Compute the solution vectors from the spectrum.
77 %
78 solV = Bc * vec;
79 %
80 % Plot the solution vectors
81 %
82 fig2 = figure;
83 for k=1:3
     plot( x, solV(:,k), 'k');
85
      hold on;
86 end;
87 title('Solution to BVP');
88 xlabel('x');
89 ylabel('y(x)');
90 grid on;
```

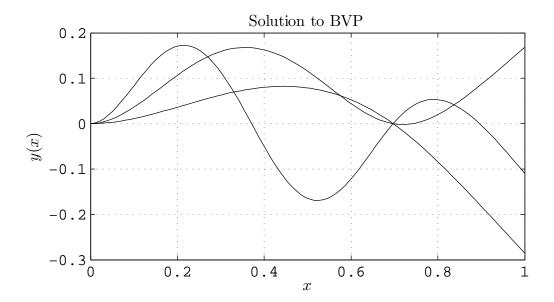


Figure 2: Eigenvectors for the Boundary Value Problem.

# 3 The spectrum of the Eigenvectors w.r.t. the Admissible Functions

The method implemented here is a discrete equivalent of a Rayleigh-Ritz method. The constrained polynomials are used for the series approximation. The vec matrix contains the spectrum. Only the specrum of the first 4 eigenvectors w.r.t. the first 10 basis functions are displayed here.

```
91 disp('The spectrum of the first 4 eigenvectors with respect to the first
92 disp('10 basis functions');
93 vec(1:10,1:4)
The spectrum of the first 4 eigenvectors with respect to the first
10 basis functions
ans =
    0.9790
              0.1863
                       0.0260
                                 -0.0002
    0.2021
             -0.9539
                       -0.2252
                                 -0.0505
                       -0.9354
   -0.0282
              0.2332
                                 -0.1464
   -0.0011
              0.0063
                       -0.2500
                                  0.8095
```

0.5598

0.0796

0.0235

0.0225

0.0069

-0.0032

0.0037

0.0021

0.0007

0.0004

0.0000

-0.0000

-0.0274

-0.0131

0.0005

-0.0043

-0.0022

-0.0001

0.0906

0.0525

0.0012

0.0120

0.0059

-0.0002

### References

[1] Paul O'Leary and Matthew Harker. A framework for the evaluation of inclinometer data in the measurement of structures. *IEEE T. Instrumentation and Measurement*, 61(5):1237–1251, 2012.